SN54HC153, SN74HC153
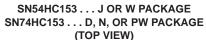## DUAL 4-LINE TO 1-LINE DATA SELECTORS/MULTIPLEXERS

- **Permit Multiplexing from n Lines to One Line**
- **Perform Parallel-to-Serial Conversion**
- **Strobe (Enable) Line Provided for Cascading (N Lines to n Lines)**
- **Package Options Include Plastic Small-Outline (D), Thin Shrink Small-Outline (PW), and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs**

SN54HC153 . . . J OR W PACKAGE
SN74HC153 . . . D, N, OR PW PACKAGE
(TOP VIEW)

```
         ___
    1G  [ 1      16 ]  V_CC
     B  [ 2      15 ]  2G
   1C3  [ 3      14 ]  A
   1C2  [ 4      13 ]  2C3
   1C1  [ 5      12 ]  2C2
   1C0  [ 6      11 ]  2C1
    1Y  [ 7      10 ]  2C0
   GND  [ 8       9 ]  2Y
```

SN54HC153 . . . FK PACKAGE
(TOP VIEW)

```
          B  1G  NC  V_CC  2G
          3   2   1   20  19
   1C3 [ 4            18 ] A
   1C2 [ 5            17 ] 2C3
    NC [ 6            16 ] NC
   1C1 [ 7            15 ] 2C2
   1C0 [ 8            14 ] 2C1
          9  10  11  12  13
         1Y GND  NC  2Y  2C0
```

NC – No internal connection

description

Each of these data selectors/multiplexers contains inverters and drivers to supply full binary decoding data selection to the AND-OR gates. Separate strobe ($\overline{G}$) inputs are provided for each of the two 4-line sections.
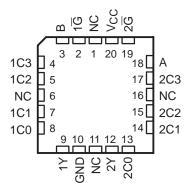
The SN54HC153 is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74HC153 is characterized for operation from –40°C to 85°C.

FUNCTION TABLE

INPUTS							OUTPUT
SELECT†		DATA				$\overline{G}$	Y
B	A	C0	C1	C2	C3		
X	X	X	X	X	X	H	L
L	L	L	X	X	X	L	L
L	L	H	X	X	X	L	H
L	H	X	L	X	X	L	L
L	H	X	H	X	X	L	H
H	L	X	X	L	X	L	L
H	L	X	X	H	X	L	H
H	H	X	X	X	L	L	L
H	H	X	X	X	H	L	H

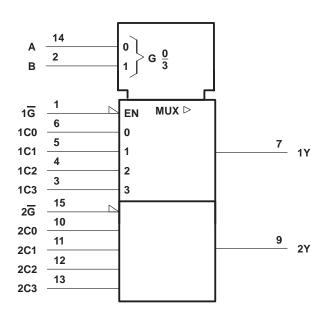† Select inputs A and B are common to both sections.

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.
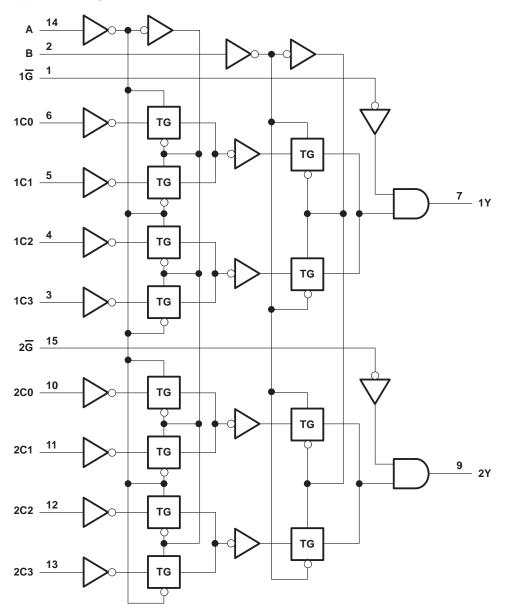
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logic symbol†

† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.
Pin numbers shown are for the D, J, N, PW, and W packages.

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logic diagram (positive logic)

Pin numbers shown are for the D, J, N, PW, and W packages.

absolute maximum ratings over operating free-air temperature range†

Supply voltage range, V_{CC} . . . . –0.5 V to 7 V
Input clamp current, I_{IK} ($V_I < 0$ or $V_I > V_{CC}$) (see Note 1) . . . . ±20 mA
Output clamp current, I_{OK} ($V_O < 0$ or $V_O > V_{CC}$) (see Note 1) . . . . ±20 mA
Continuous output current, I_O ($V_O = 0$ to V_{CC}) . . . . ±35 mA
Continuous current through V_{CC} or GND . . . . ±70 mA
Package thermal impedance, θ_{JA} (see Note 2): D package . . . . 113°C/W
N package . . . . 78°C/W
PW package . . . . 149°C/W
Storage temperature range, T_{stg} . . . . –65°C to 150°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.
2. The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.

recommended operating conditions

			SN54HC153			SN74HC153			UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage		2	5	6	2	5	6	V
V_{IH}	High-level input voltage	V_{CC} = 2 V	1.5			1.5			V
		V_{CC} = 4.5 V	3.15			3.15			
		V_{CC} = 6 V	4.2			4.2			
V_{IL}	Low-level input voltage	V_{CC} = 2 V	0		0.5	0		0.5	V
		V_{CC} = 4.5 V	0		1.35	0		1.35	
		V_{CC} = 6 V	0		1.8	0		1.8	
V_I	Input voltage		0		V_{CC}	0		V_{CC}	V
V_O	Output voltage		0		V_{CC}	0		V_{CC}	V
t_t	Input transition (rise and fall) time	V_{CC} = 2 V	0		1000	0		1000	ns
		V_{CC} = 4.5 V	0		500	0		500	
		V_{CC} = 6 V	0		400	0		400	
T_A	Operating free-air temperature		–55		125	–40		85	°C

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

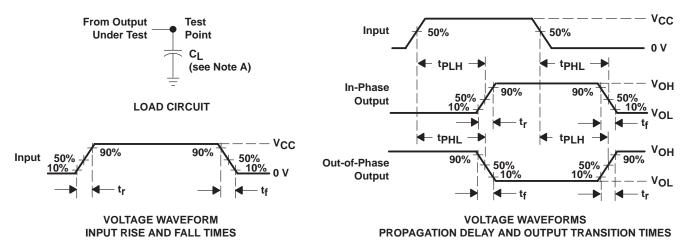| PARAMETER	TEST CONDITIONS		V_{CC}	$T_A = 25°C$			SN54HC153		SN74HC153		UNIT
				MIN	TYP	MAX	MIN	MAX	MIN	MAX	
V_{OH}	$V_I = V_{IH}$ or V_{IL}	$I_{OH} = -20\ \mu A$	2 V	1.9	1.998		1.9		1.9		V
			4.5 V	4.4	4.499		4.4		4.4		
			6 V	5.9	5.999		5.9		5.9		
		$I_{OH} = -6\ mA$	4.5 V	3.98	4.3		3.7		3.84		
		$I_{OH} = -7.8\ mA$	6 V	5.48	5.8		5.2		5.34		
V_{OL}	$V_I = V_{IH}$ or V_{IL}	$I_{OL} = 20\ \mu A$	2 V		0.002	0.1		0.1		0.1	V
			4.5 V		0.001	0.1		0.1		0.1	
			6 V		0.001	0.1		0.1		0.1	
		$I_{OL} = 6\ mA$	4.5 V		0.17	0.26		0.4		0.33	
		$I_{OL} = 7.8\ mA$	6 V		0.15	0.26		0.4		0.33	
I_I	$V_I = V_{CC}$ or 0		6 V		±0.1	±100		±1000		±1000	nA
I_{CC}	$V_I = V_{CC}$ or 0, $I_O = 0$		6 V			8		160		80	μA
C_i			2 V to 6 V		3	10		10		10	pF

switching characteristics over recommended operating free-air temperature range, C_L = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC}	$T_A = 25°C$			SN54HC153		SN74HC153		UNIT
				MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_{pd}	A or B	Y	2 V		90	150		225		190	ns
			4.5 V		21	30		45		38	
			6 V		17	26		38		32	
	Data (Any C)	Y	2 V		73	126		189		158	
			4.5 V		17	28		42		35	
			6 V		14	23		35		29	
	$\overline{G}$	Y	2 V		38	95		150		125	
			4.5 V		11	19		28		24	
			6 V		9	16		24		20	
t_t		Y	2 V		20	60		90		75	ns
			4.5 V		8	12		18		15	
			6 V		6	10		15		13	

switching characteristics over recommended operating free-air temperature range, C_L = 150 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC}	$T_A = 25°C$			SN54HC153		SN74HC153		UNIT
				MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t_{pd}	A or B	Y	2 V		105	235		355		295	ns
			4.5 V		27	47		71		59	
			6 V		21	41		60		51	
	Data (Any C)	Y	2 V		93	220		335		274	
			4.5 V		23	44		67		55	
			6 V		19	38		57		48	
	$\overline{G}$	Y	2 V		60	185		280		230	
			4.5 V		17	37		56		46	
			6 V		14	32		48		40	
t_t		Y	2 V		45	210		315		265	ns
			4.5 V		17	42		63		53	
			6 V		13	36		53		45	

operating characteristics, T_A = 25°C

PARAMETER		TEST CONDITIONS	TYP	UNIT
C_{pd}	Power dissipation capacitance per multiplexer	No load	40	pF

PARAMETER MEASUREMENT INFORMATION

LOAD CIRCUIT

**VOLTAGE WAVEFORM
INPUT RISE AND FALL TIMES**

**VOLTAGE WAVEFORMS
PROPAGATION DELAY AND OUTPUT TRANSITION TIMES**

NOTES: A. C_L includes probe and test-fixture capacitance.
   B. Phase relationships between waveforms were chosen arbitrarily. All input pulses are supplied by generators having the following characteristics: PRR ≤ 1 MHz, Z_O = 50 Ω, t_r = 6 ns, t_f = 6 ns.
   C. The outputs are measured one at a time with one input transition per measurement.
   D. t_{PLH} and t_{PHL} are the same as t_{pd}.

Figure 1. Load Circuit and Voltage Waveforms

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